Search Notes		
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/813,383	DAVEY ET AL.	
Examiner	Art Unit	
Stacy B. Chen	1648	

Subclass	Date	Examiner
		<u> </u>

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
<u> </u>	<u> </u>			

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
uspat, uspgpub, epo, jpo, derwent, medline, embase, biosis; see search history in file	10/28/2005	SF
PALM/EAST inventorship; updated	6/20/2006	SBC
updated	3/8/2007	SBC
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